Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/551,007	DENECKE ET AL.	
Examiner	Art Unit	_
Ninh H. Nguyen	3745	

	SEAR	CHED	
Class	Subclass	Date	Examiner
416	134A	3/26/2007	NHN
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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East search	3/26/2007	NHN
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